





NPN General Purpose Amplifier

This device is designed for use as general purpose amplifiers and switches requiring collector currents to 100 mA.

Absolute Maximum Ratings* TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units
V _{CEO}	Collector-Emitter Voltage	30	V
V _{CBO}	Collector-Base Voltage	40	V
V _{EBO}	Emitter-Base Voltage	5.0	V
Ic	Collector Current - Continuous	200	mA
T _J , T _{stg}	Operating and Storage Junction Temperature Range	-55 to +150	°C

*These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

NOTES: 1) These ratings are based on a maximum junction temperature of 150 degrees C. 2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Thermal Characteristics TA = 25°C unless otherwise noted

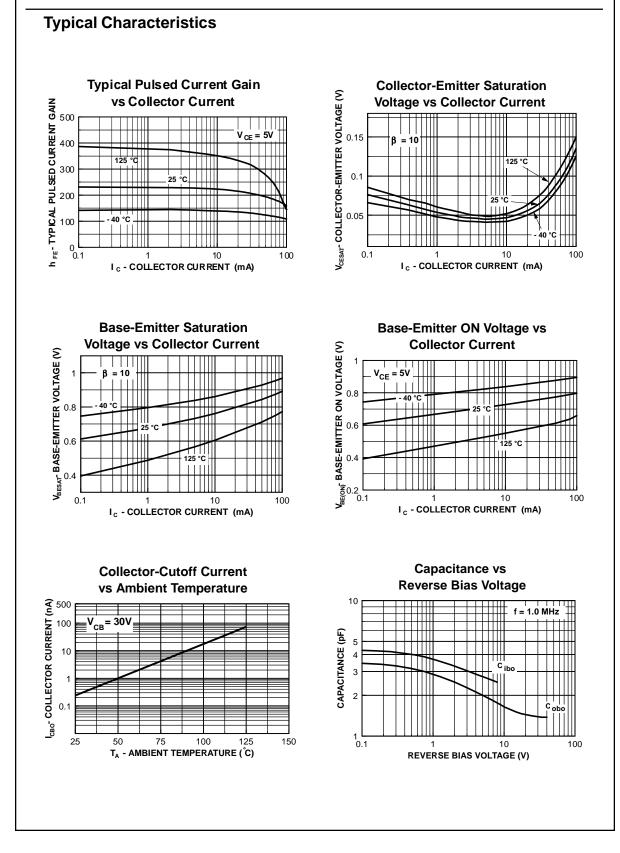
Symbol	Characteristic	Max	Units
		2N4123	
P _D	Total Device Dissipation Derate above 25°C	625 5.0	mW mW/°C
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	83.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	200	°C/W

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NPN General Purpose Amplifier (continued)

Symbol	Parameter	Test Conditions	Min	Max	Units
OFF CHA	RACTERISTICS			-	
V _{(BR)CEO}	Collector-Emitter Breakdown Voltage*	$I_{\rm C} = 1.0 \text{ mA}, I_{\rm B} = 0$	30		V
V _{(BR)CBO}	Collector-Base Breakdown Voltage	$I_{\rm C} = 10 \ \mu A, \ I_{\rm E} = 0$	40		V
V _{(BR)EBO}	Emitter-Base Breakdown Voltage	$I_{\rm E} = 10 \ \mu {\rm A}, \ I_{\rm C} = 0$	5.0		V
сво	Collector Cutoff Current	$V_{CB} = 20 \text{ V}, \text{ I}_{E} = 0$		50	nA
EBO	Emitter Cutoff Current	$V_{EB} = 3.0 \text{ V}, I_{C} = 0$		50	nA
	ACTERISTICS* DC Current Gain	V _{CE} = 1.0 V, I _C = 2.0 mA	50	150	
IFE	De Callon Call	$V_{ar} = 1.0 V I_{a} = 50 mA$	25		
	Collector-Emitter Saturation Voltage	$V_{CE} = 1.0 \text{ V}, I_C = 50 \text{ mA}$ $I_C = 50 \text{ mA}, I_B = 5.0 \text{ mA}$	25	0.3	V
h _{FE} V _{CE(sat)} V _{BE(sat)}	Collector-Emitter Saturation Voltage Base-Emitter Saturation Voltage		25	0.3 0.95	V V
V _{CE(sat)} V _{BE(sat)} SMALL S	Collector-Emitter Saturation Voltage	$I_{\rm C} = 50$ mA, $I_{\rm B} = 5.0$ mA	25		
V _{CE(sat)} V _{BE(sat)} SMALL S C _{ob}	Collector-Emitter Saturation Voltage Base-Emitter Saturation Voltage	$I_{c} = 50$ mA, $I_{B} = 5.0$ mA $I_{c} = 50$ mA, $I_{B} = 5.0$ mA	25	0.95	V
V _{CE(sat)} V _{BE(sat)}	Collector-Emitter Saturation Voltage Base-Emitter Saturation Voltage IGNAL CHARACTERISTICS Output Capacitance	$\begin{split} I_{C} &= 50 \text{ mA}, I_{B} = 5.0 \text{ mA} \\ I_{C} &= 50 \text{ mA}, I_{B} = 5.0 \text{ mA} \\ \end{split}$ $\begin{split} V_{CB} &= 5.0 \text{ V}, f = 100 \text{ kHz} \\ V_{EB} &= 0.5 \text{ V}, f = 0.1 \text{ MHz} \\ I_{C} &= 2.0 \text{ mA}, V_{CE} = 10 \text{ V}, \\ f &= 1.0 \text{ kHz} \\ I_{C} &= 10 \text{ mA}, V_{CE} = 20 \text{ V}, \end{split}$	50	0.95 4.0	V
V _{CE(sat)} V _{BE} (sat) SMALL S C _{ob} C _{ib}	Collector-Emitter Saturation Voltage Base-Emitter Saturation Voltage IGNAL CHARACTERISTICS Output Capacitance Input Capacitance	$\begin{split} I_{C} &= 50 \text{ mA}, I_{B} = 5.0 \text{ mA} \\ I_{C} &= 50 \text{ mA}, I_{B} = 5.0 \text{ mA} \\ \end{split}$ $\begin{split} V_{CB} &= 5.0 \text{ V}, f = 100 \text{ kHz} \\ V_{EB} &= 0.5 \text{ V}, f = 0.1 \text{ MHz} \\ I_{C} &= 2.0 \text{ mA}, V_{CE} = 10 \text{ V}, \\ f &= 1.0 \text{ kHz} \end{split}$		0.95 4.0 8.0	V

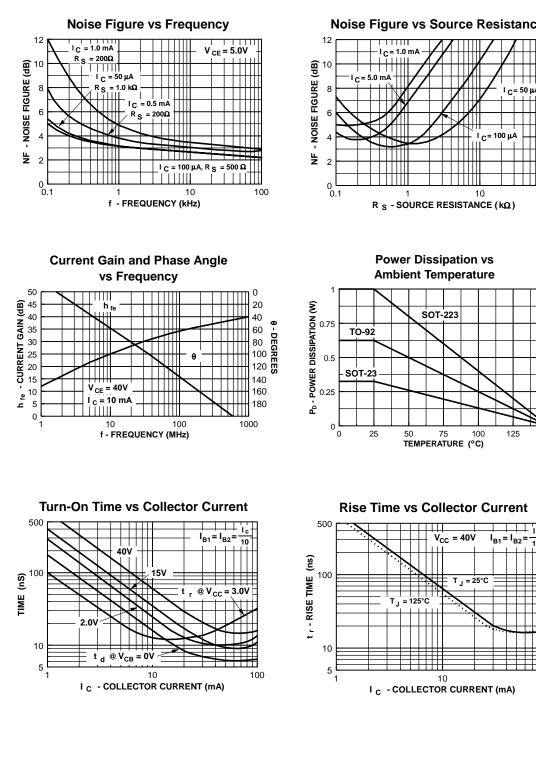
NPN General Purpose Amplifier (continued)



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NPN General Purpose Amplifier

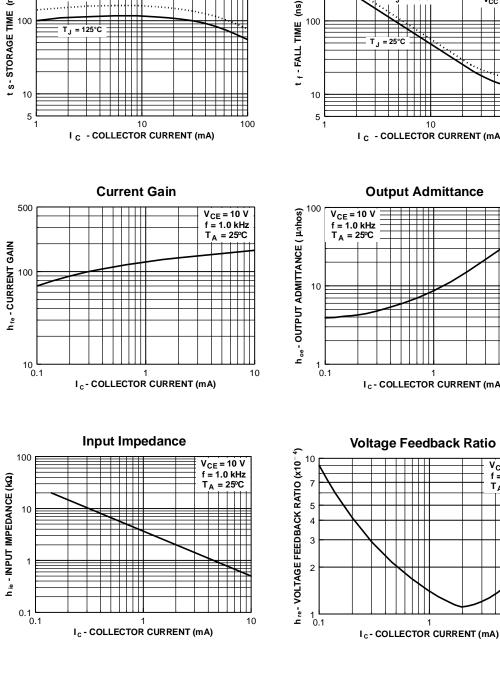
(continued) **Typical Characteristics** (continued) **Noise Figure vs Source Resistance** 12 $V_{CE} = 5.0V$ c=1.0 m NF - NOISE FIGURE (dB) 5.0 mA Ι_C= 50 μΑ I_C = 0.5 mA $R_{S} = 200\Omega$ i IIII ΗÞ Ι_C= 100 μΑ $I_{C} = 100 \,\mu\text{A}, R_{S} = 500 \,\Omega$ ttt 0 0.1 1 10 100 10 100 1 f - FREQUENCY (kHz) R _S - SOURCE RESISTANCE ($k\Omega$) **Power Dissipation vs Ambient Temperature** vs Frequency 0 20 **P**^D - **DOMER DISSIPATION (W)** 0.5 0.25 SOT-223 40 40 60 - DEGREES TO-92 ---θ SOT-23 140 160 180 0 **L** 0 100 1000 10 f - FREQUENCY (MHz) 25 50 75 100 TEMPERATURE (°C) 125 150 **Rise Time vs Collector Current** 500 $V_{CC} = 40V$ I_{B1} = I_{B2} = I_{B1} = I_{B2}= 10 40V 15V 100 T _J = 25°C @ V_{CC} = 3.0V т 25°C





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NPN General Purpose Amplifier (continued) Typical Characteristics (continued) Storage Time vs Collector Current Fall Time vs Collector Current 500 1 1 $I_{B1} = I_{B2} = \frac{1}{10}$ I_{B1} = I_{B2} = 10 = 25°C $V_{CC} = 40V$ 125 t _f - FALL TIME (ns) . . $\left\{\cdot \right\}$ 100 = 125°C т, = 25°C 10 5 10 100 1 10 100 I C - COLLECTOR CURRENT (mA) **Current Gain Output Admittance** 100 h_{oe} - OUTPUT ADMITTANCE ($\mu nhos)$ V_{CE} = 10 V V_{CE} = 10 V f = 1.0 kHz T_A = 25℃ f = 1.0 kHz T_A = 25°C 10 0.1 10 10 1 1 Ic-COLLECTOR CURRENT (mA) Input Impedance **Voltage Feedback Ratio** 10 V_{CE} = 10 V f = 1.0 kHz V_{CE} = 10 V f = 1.0 kHzT_A = 25℃ 7 T_∆ = 25°C 5 4 3

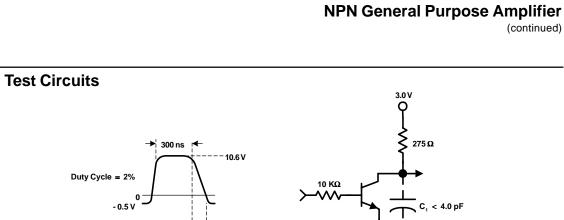


500

т_ј

τ_j

(su)



< 4.0 pF

FIGURE 1: Delay and Rise Time Equivalent Test Circuit

< 1.0 ns 🔸

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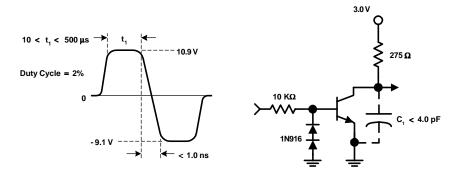


FIGURE 2: Storage and Fall Time Equivalent Test Circuit

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